Form PTO 1449		U.S. DEPARTMENT PATENT AND TRAD		ATTY DOCKET NO. 255291US90PCT		SERIAL NO. 10/502,045		
(Modified)		PATENT AND TRAL	JEMARK OFFICE					
APPLICANT								
LISTOF	KEFEI	RENCES CITED BY AP	PLICANI	Atsushi KUDO, et al.				
				FILING DATE		GROUP		
				July 29, 2004		<u> </u>		
U.S. PATENT DOCUMENTS								
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS		SUB FILING DATE CLASS IF APPROPRIATE	
	AA	5 914 187	06/22/99	NARUSE et al.				
	AB	5 930 994	08/03/99	SHIMATO et al.				
	AC	6 447 564	09/10/02	OHNO et al.				
	AD	6 565 630	05/20/03	OHNO et al.				
	AE	2004/55265	05/25/04	OHNO et al. serial no. 10/671,418				
	AF	6 669 751	12/30/03	OHNO et al.				
	AC	2004/33175	02/19/04	OHNO et al. serial no. 10/362,975				
	АН	2004/31264	02/19/04	KOJIMA, serial no. 10/296,027				
	Al	6 770 116	08/03/04	KOJIMA				
	AJ							
	AK			·				
	AL							
	AM							
	AN	· · · ·						
FOREIGN PATENT DOCUMENTS								
		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION YES NO		
	AO	2001-98936	04/10/01	JP(with English abstract and partial English translation)			NO	
	AP	98/56531	12/17/98	WO(equivalent of US 6276595)			NO	
	AQ	01/93984	12/13/01	wo			NO	
	AR	965 735	12/22/99	9			NO	
	AS	6-193429	07/12/94	JP(with English abstract and partial Eng translation)	partial English		NO	
	AT	08-028246	01/30/96	JP(with English abstract)			NO	
	AU	2001-190916	07/17/01	JP(equivalent of EP1249262)			NO	
	AV	2000-102709	04/11/00	JP(with English abstract & partial Englis translation)	sh		NO	
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)								
	AW							
	AX							
	AY							
	AZ				Addi	tional Refe	rences sheet(s) attached	
Examiner					Date Considered			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								
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